TOSHIBA SSM3K01F

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE

SSM3K01F

HIGH SPEED SWITCHING APPLICATIONS

Small Package

: Ron = $120 \,\mathrm{m}\Omega$ (Max) (VGS = $4 \,\mathrm{V}$) Low on Resistance

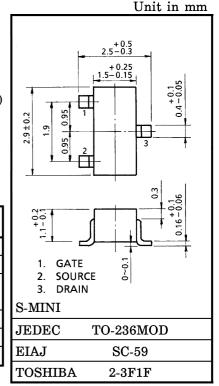
: Ron = $150 \,\mathrm{m}\Omega$ (Max) (VGS = $2.5 \,\mathrm{V}$)

Low Gate Threshold Voltage : Vth = $0.6 \sim 1.1 \, \mathrm{V}$

 $(V_{DS} = 3 V, I_{D} = 0.1 mA)$

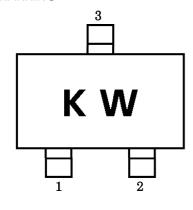
MAXIMUM RATINGS (Ta = 25°C)

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CHARACTERISTIC		SYMBOL	RATING	UNIT
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		v_{GSS}	±10	V
Drain Current	DC	$I_{\mathbf{D}}$	1.3	_
	Pulse	I_{DP}	2.6	A
Drain Power Dissipation		$P_{\mathbf{D}}$	200	mW
Channel Temperature		$T_{ m ch}$	150	$^{\circ}\mathrm{C}$
Storage Temperature Range		$T_{ m stg}$	-55~150	°C

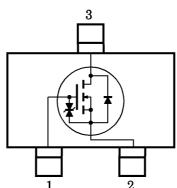


Weight: 0.012 g

MARKING







HANDLING PRECAUTION

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials. 961001EAA1

TOSHIBA is continually working to improve the quality and the reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to observe standards of safety, and to avoid situations in which a malfunction or failure of a TOSHIBA product could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent products specifications. Also, please keep in mind the precautions and conditions set forth in the TOSHIBA Semiconductor Reliability Handbook.

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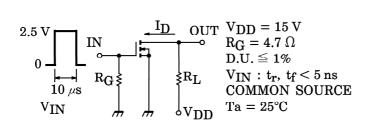
TOSHIBA

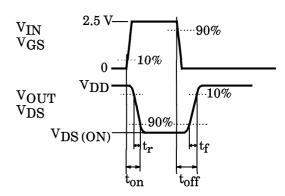
ELECTRICAL CHARACTERISTICS (Ta	=	25°C)
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CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current	$I_{ m GSS}$	$V_{GS} = \pm 10 V, V_{DS} = 0$	_		±5	μ A
Drain-Source Breakdow Voltage	v (BR) DSS	$I_D = 1 \text{ mA}, V_{GS} = 0$	30	_	_	V
Drain Cut-off Current	$I_{ m DSS}$	$V_{DS} = 30 \text{ V}, V_{GS} = 0$	_	_	1	μ A
Gate Threshold Voltage	$v_{ m th}$	$V_{\mathrm{DS}} = 3 \mathrm{V}, \; \mathrm{I_D} = 0.1 \mathrm{mA}$	0.6		1.1	V
Forward Transfer Admittance	Y _{fs}	$V_{DS} = 3 \text{ V}, I_{D} = 0.65 \text{ A}$ (Note 1)	2.0	_	_	S
Drain-Source ON Resist	ance R _{DS} (ON)	$I_D = 0.65 \text{ A}, V_{GS} = 4V$ (Note 1) $I_D = 0.65 \text{ A}, V_{GS} = 2.5 \text{ V}$ (Note 1)	_	85 115	120 150	$\mathbf{m}\Omega$
Input Capacitance	$\mathrm{c}_{\mathrm{iss}}$	$V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	_	152	_	pF
Reverse Transfer Capacitance	$\mathrm{C}_{\mathrm{rss}}$	$V_{ m DS} = 10 \ m V, \ V_{ m GS} = 0, \ m f = 1 \ m MHz$	_	41	_	pF
Output Capacitance	Coss	$V_{DS} = 10 \text{ V}, \ V_{GS} = 0, \ f = 1 \text{ MHz}$	_	102	_	pF
Switching Turn-on T	ime t _{on}	$V_{DD} = 15 \text{ V}, I_{D} = 0.5 \text{ A},$	_	45	_	n a
Time Turn-off T	ime t _{off}	$V_{GS} = 0 \sim 2.5 \text{ V}, R_{G} = 4.7 \Omega$	_	69	_	ns

(Note 1): Pulse test

SWITCHING TIME TEST CIRCUIT



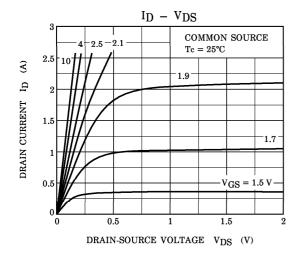


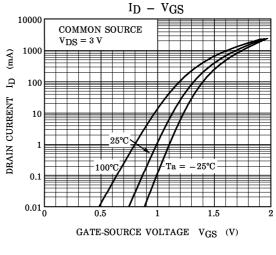
PRECAUTION

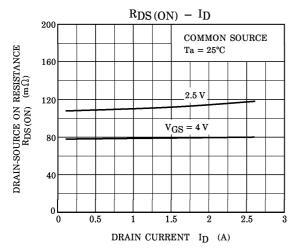
Vth can be expressed as voltage between gate and source when low operating current value is $I_D=100~\mu A$ for this product. For normal switching operation, $V_{GS\,(ON)}$ requires higher voltage than V_{th} and $V_{GS\,(off)}$ requires lower voltage than $V_{th}.$ (Relationship can be established as follows: $V_{GS\,(off)} < V_{th} < V_{GS\,(ON))}$

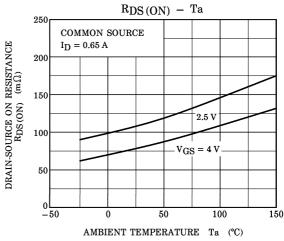
Please take this into consideration for using the device.

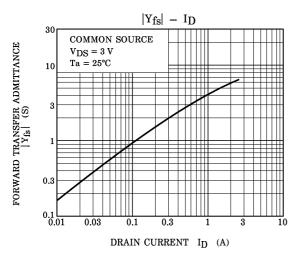
VGS recommended voltage of 2.5 V or higher to turn on this product.

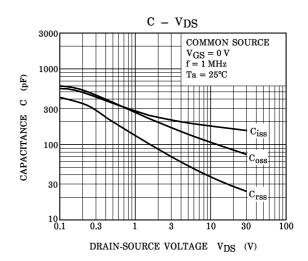


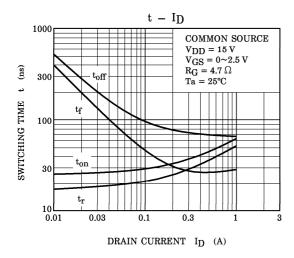


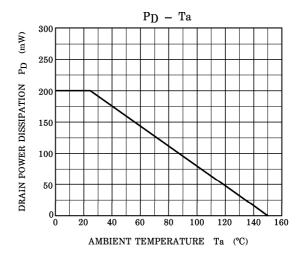


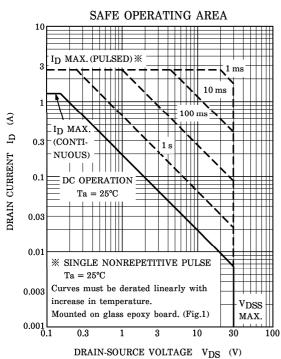












(Fig.1) : 25.4 mm \times 25.4 mm \times 1.6 t(a Cu pad of 0.8 mm² area)

